

Notice of References Cited

Application/Control No.

10/045,354

Applicant(s)/Patent Under

R² examination

HUI ET AL.

Examiner

Khiem D Nguyen

Art Unit

2823

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,270,265	12-1993	Hemmenway et al.	438/404
	B	US-6,159,844	12-2000	Bothra, Subhas	438/637
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	U.S. Pub. 2002/0117706 Shimizu (Aug. 29, 2002).
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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